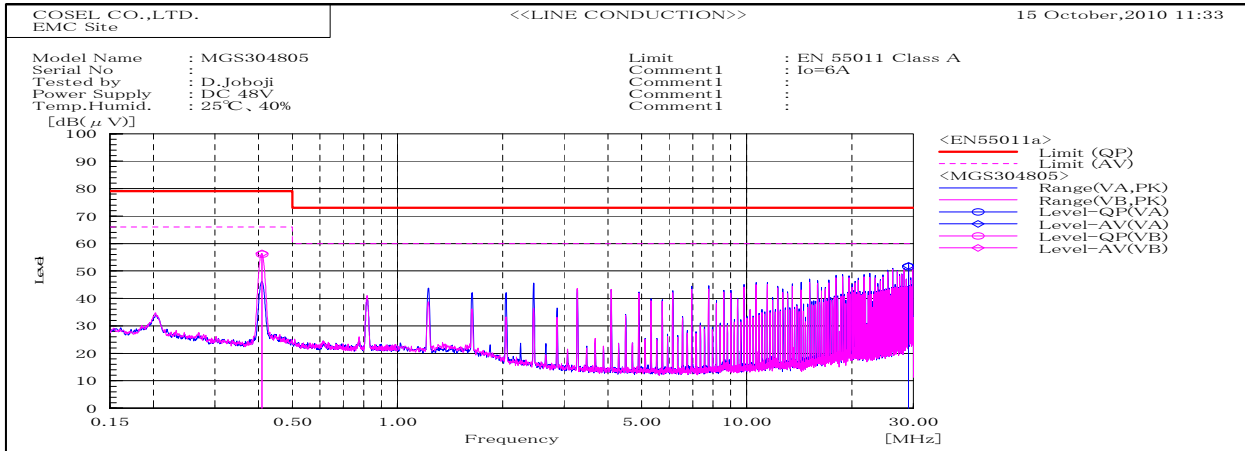
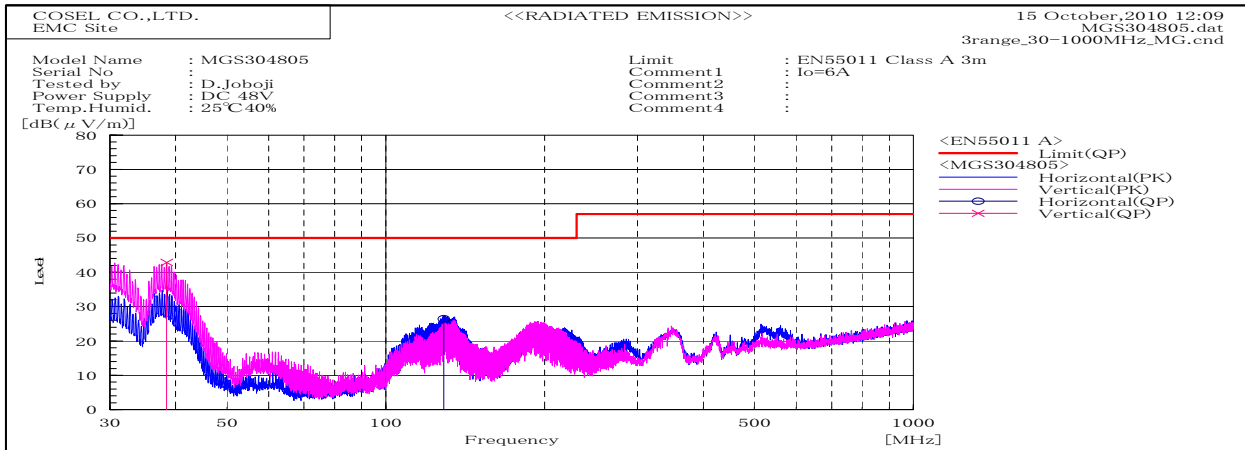


DATA SHEET		Date	19-Oct-10
Model	MGS304805	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	D.Joboji



Frequency MHz	Harm	Line Phase	Reading dB(μV)		Factor dB	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.40924		VB	46.1	46.4	10	56.1	56.4	79	66	22.9	9.6	Pass	
29.034		VA	40.9	41.2	10.7	51.6	51.9	73	60	21.4	8.1	Pass	

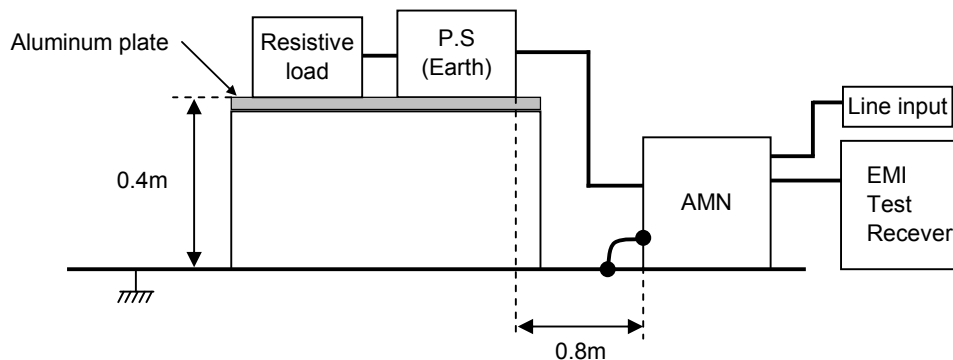


Frequency MHz	Polarization	Stability	Reading dB(μV)		Space Loss dB	Level dB(mW)		Limit dB(mW)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV		QP	AV						
38.447	V	Stable	60.7		-17.8	42.9		50	7.1	Pass	115	0	
128.829	H	Stable	46.1		-19.7	26.4		50	23.6	Pass	148	302	

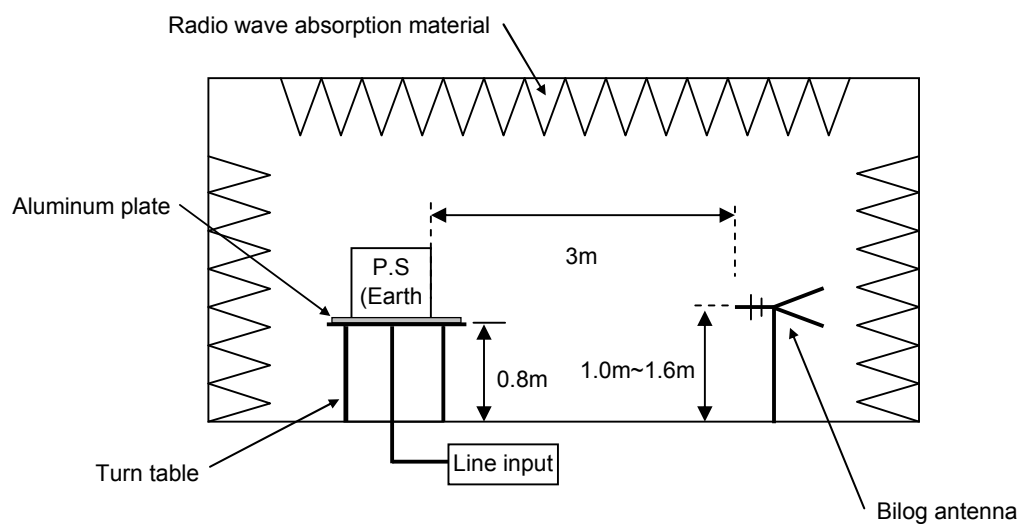
DATA SHEET

Model	Circuit used for measurement
Test	EMI Line conduction & Radiated emission

1. Line conduction



2. Radiated emission



Conditions

Test : EMI
 Model Name : MGS3048□□/MGW3048□□

○Photographs of Test Set-Up

LINE CONDUCTION



RADIATED EMISSION



○Testing circuitry

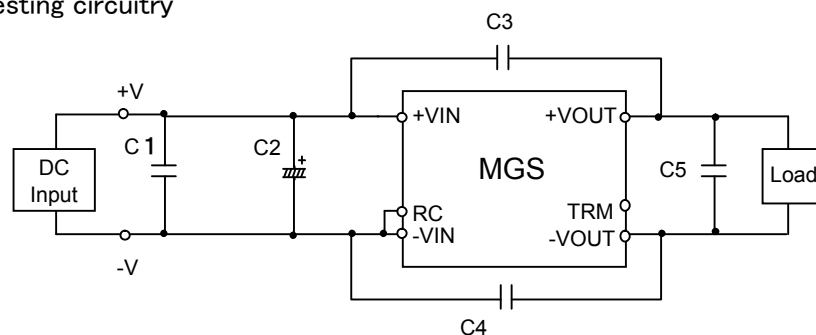


Fig.1 Testing circuitry 1

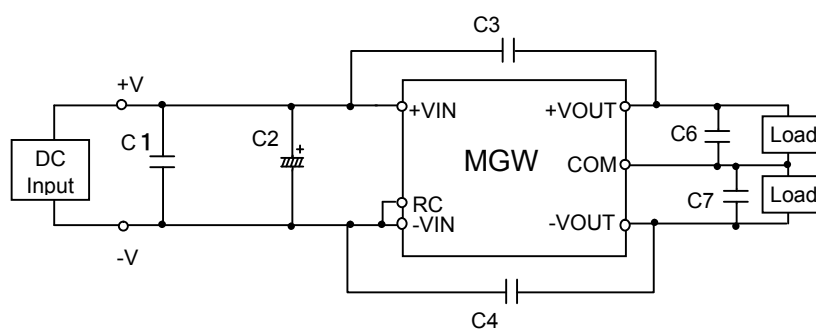


Fig.2 Testing circuitry 2

C1	:	100V	2.2 μ F	Ceramic Capacitor
C2	:	80V	47 μ F	Electrolytic Capacitor
C3,C4	:	2kV	1000pF	Ceramic Capacitor
C5,C6,C7	:	25V	22 μ F	Ceramic Capacitor